**23EC2102- ELECTRONIC DEVICES & CIRCUITS**

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| **CourseCategory:** | | Professional Core | | **Credits:** | 3 |
| **CourseType:** | | Theory | | **Lecture-Tutorial-**  **Practical:** | 3-0-0 |
| **Prerequisite:** | | Semiconductor Physics, Network Theory,Fourier Series | | **Sessional Evaluation:Univ.ExamEvaluation:**  **TotalMarks:** | 30  70  100 |
| **CourseObjectives** | | 1. Students will be able to understand the basic principles of all semiconductor devices. 2. Able to analyze diode circuits, various biasing, and small signal equivalent circuits of amplifiers, compare the performance of BJTs and MOSFETs 3. Able to design rectifier circuits and various amplifier circuits using BJTs and MOSFETs. | | | |
| **CourseOutcomes** | Upon successful completion of the course,the students will be able to: | | | | |
| CO1 | | Understand the principle of operation, characteristics ,and applications of semiconductor diodes, special diodes,BJTs,JFET,andMOSFETs.(L2) | | |
| CO2 | | Applying the basic principles of solving the problems related to Semiconductor diodes, BJTs ,and MOSFETs.(L3) | | |
| CO3 | | Analyzediodecircuitsfordifferentapplicationssuchasrectifiers,clippers and clampers also analyze biasing circuits of BJTs, and MOSFETs.(L4) | | |
| CO4 | | Design of diode circuits and amplifiers using BJTs, and MOSFETs. (L4) | | |
| CO5 | | Compare the performance of various semiconductor devices.(L4) | | |
| **CourseContent** | **UNIT-I**  **PN junction diode:** Review, Diode current equation, Diode resistance, Transition and Diffusion Capacitance ,Effect of temperature on PN junction diode, Quantitative analysis of Half-wave, Full-wave and Bridge Rectifiers with and without Filters, Ripple Factor and Regulation Characteristics, Clipping and Clamping circuits ,Illustrative problems.  **Special Diodes:** Construction, operation and VI characteristics of Tunnel Diode ,Varactor Diode ,LED ,LCD, PhotoDiode, SCR and UJT.  **UNIT-II**  Review of Bipolar Junction Transistors, Characteristics, Transistor as an Amplifier and as a Switch,BJT Configurations,Limits of Operation,BJT specification.  **Biasing and Stabilization:** Operating Point, DC and AC Load Lines, Importance of Biasing ,Fixed Bias, Collector to Base Bias, Self-Bias, Bias Stability, Thermal Runaway, ThermalStability, Illustrative problems.  **UNIT-III**  BJT Small Signal Operation and Models- the transconductance, input resistance at the base, input resistance at the emitter, Voltage gain, separating the Signal and the DC Quantities, The Hybrid π Model, the T Model. Single Stage BJT Amplifiers - Common-Emitter (CE) amplifier without and with emitter resistance ,Common-Base(CB) amplifier, Common-Collector(CC) amplifier or Emitter Follower,Problem solving. | | | | |
|  | **UNIT-IV**  **Junction Field Effect Transistor (FET):** Construction, Principle of Operation, V–I Characteristics, Comparison of BJT and FET, FET as Voltage Variable Resistor. FET biasing.  **MOS Field Effect Transistors:** Introduction ,Device Structure and Physical Operation, CMOS, V - I Characteristics, MOSFET Circuits at DC, MOSFET as an Amplifier and as a Switch. Biasing in MOS Amplifier circuits - biasing by fixing VGS with and without source resistance, biasing using drain to gate feedback resistor, biasing using constant current source ,body effect, Problem solving.  **UNIT-V**  MOSFET Small Signal Operation Models– the DC bias, separating the DC analysis and the signal analysis, Small signal equivalent circuit models, the transconductance, the T equivalent circuit model, Single stage MOS Amplifiers–common source (CS) amplifier without and with source resistance ,common gate (CG) amplifier ,source follower, Problem solving. | | | | |
| **Text Books&ReferenceBooks** | **TEXTBOOKS:**   1. AdelS.SedraandKennethC.Smith,“MicroelectronicCircuits–TheoryandApplications”,6th Edition,OxfordPress,2013. 2. J.MillimanandCHalkias,“Integratedelectronics”,2ndEdition,TataMcGrawHill,1991.   **REFERENCEBOOKS:**   1. DonaldA.Neamen,“ElectronicCircuits–analysisanddesign”,3rdEdition,McGrawHill(India),2019. 2. BehzadRazavi,“Microelectronics”,Secondedition,Wiley,2013. 3. R.L. Boylestadand Louis Nashelsky, “ElectronicDevicesandCircuits,”9thEdition,Pearson,2006. 4. Jimmie J Cathey, “Electronic Devices and Circuits,” Schaum’soutlinesseries,3rdedition, McGraw-Hill(India),2010. | | | | |

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| Contribution of Course Outcomes towards achievement of Program Outcomes (3-High, 2-Medium, 1-Low) | | | | | | | | | | | | | | |
|  | PO1 | PO2 | PO3 | PO4 | PO5 | PO6 | PO7 | PO8 | PO9 | PO10 | PO11 | PO12 | PSO1 | PSO2 |
| CO1 | 3 | 3 | 2 | - | - | - | - | - | - | - | - | - | 3 | 2 |
| CO2 | 3 | 3 | 3 | 3 | - | - | - | - | - | - | - | - | 3 | 2 |
| CO3 | 3 | 3 | - | - | - | - | - | - | - | - | - | - | 3 | 2 |
| CO4 | 3 | 3 | 3 | - | - | - | - | - | - | - | - | - | 3 | 2 |
| CO5 | 3 | 3 | - | - | - | - | - | - | - | - | - | - | 3 | 2 |